

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No.: 10/821,751) Group Art Unit: 2891)
Filing Date: December 30, 2002) Examiner: Yevsikov, Victor V.)
For: Surface Treatment Using Iodine Plasma) Docket No: 101.114
To Improve Metal Deposition)

) Confirmation No.: 1874

Paper No.:

MAIL STOP AMENDMENT COMMISSIONER FOR PATENTS P.O. BOX 1450 ALEXANDRIA, VA 22313-1450

Dalton et al.

Sir:

Inventors:

This Amendment and Remarks is in response to the Office Action mailed June 15, 2005. In accordance with 37 CFR 1.132, a Declaration Of Sanjay Gopinath is attached.

AMENDMENTS TO SPECIFICATION

Please delete and replace a paragraph, as follows.

Please delete the paragraph in the specification at page 3, lines 1—18:

Deleted paragraph:

Pretreating a substrate surface with iodine has been reported to increase the growth rate of copper deposited by a MOCVD technique using Cu(hfac)TMVS precursor. United States Patent No. 6,413,864 issued July 2, 2002 to Pyo et al., discloses forming a chemical enhancement layer (CE layer) on a nitride barrier layer surface (e.g.,TiN, TaN, WN) with an iodine-containing liquid compound prior to forming a copper seed layer by MOCVD, and then electroplating a second copper layer onto the seed layer. United States Patent No.

Serial No. 10/821,751 Amendment And Remarks In Response To Office Action Mailed 06/15/05 Page 1 IFW